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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 1 of 1

Complete if Known	
Application Number	09/739,391
Filing Date	12/15/2000
First Named Inventor	Ronald P. Reade
Art Unit	1765
Examiner Name	Robert M. Kunemund
Attorney Docket Number	IB-1632

U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Document Number Number-Kind Code[2] (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-			
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FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Foreign Patent Document Country Code[3] Number[4] Kind Code[5] (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T[6]
		JP 01215966 A	09/1989	Yamaki et al.		
		JP 07-065642	10/1995	Yasuhiro		

Examiner Signature		Date Considered	8/23/04

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		JP 01215966 A	09/1989	Yamaki et al.		
		JP 07-065642	10/1995	Yasuhiro		

Examiner Signature		Date Considered	8/18/04

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INFORMATION DISCLOSURE CITATION

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ATTY DOCKET NO.	SERIAL NO.
IB-1632	09/739,391
RONALD P. READE	
FILING	GROUP
DECEMBER 15, 2000	1765

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,262,394	11/1993	Wu et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
		01/08169	07/2000	WIPO				
		01/08170	07/2000	WIPO				
		01/08231	07/2000	WIPO				
		01/08232	07/2000	WIPO				
		01/08235	07/2000	WIPO				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

			Wiesmann, J. et al.; "LARGE-AREA OF BIAXIALLY TEXTURED YSZ BUFFER LAYERS USING AN IBAD PROCESS," Nuclear Instruments and Methods in Physics Research B, Vol. 120, pp. 290-292, (1996).

EXAMINER	DATE CONSIDERED
	6/29/04

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IB-1632	09/739,391
RONALD P. READE	
FILING	GROUP
DECEMBER 15, 2000	1765

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
		01/08236	07/2000	WIPO				
		99/16941	09/1998	WIPO				
		01/08233	07/2000	WIPO				
		01/26165	07/2000	WIPO				
		98/58415	06/1998	WIPO				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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	8/23/04

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INFORMATION DISCLOSURE CITATION

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ATTY DOCKET NO.	SERIAL NO.
IB-1632	09/739,391
RONALD P. READE	
FILING	GROUP
DECEMBER 15, 2000	1765

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
		01/15245	07/2000	WIPO				
		01/26164	07/2000	WIPO				
		00/58530	03/2000	WIPO				
		99/17307	09/1998	WIPO				
		01/11428	07/2000	WIPO				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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ATTY DOCKET NO.	SERIAL NO.
IB-1632	09/739,391
RONALD P. READE	
FILING: DECEMBER 15, 2000	GROUP: 1765

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
R		00/58044	01/2000	WIPO				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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	5/23/04

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FORM PTO-1449 (Modified) U.S. Department of Commerce, Patent and Trademark Office	Docket No. IB-1632	Serial No. 09/739,391
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Applicant Ronald P. Reade et al.	
	Filing Date December 15, 2000	Group Unknown

OIPE JC51 JUN 0 7 2004 PATENT & TRADEMARK OFFICE

U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,262,394	11/16/93	Wu et al.	505	1	12/27/91
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents

							Translation	
		Document Number	Date	Country	Class	Subclass	Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	Wiesmann, J., et al., "Large-Area Deposition of Biaxially Textured YSZ Buffer Layers Using an IBAD-Process", Nucl. Instr. and Meth. in Phys. Res. B 120, 1996, pp. 290-292.
	AS	
	AT	

Examiner	Date Considered
	8/03/04

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FORM PTO-1449 (Modified)
U.S. Department of Commerce, Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

OIPE SC1617 JUN 07 2004 PATENT & TRADEMARK OFFICE

Docket No.	Serial No.
IB-1632	
Applicant	
Ronald P. Reade et al.	
Filing Date	Group
Herewith	Unknown

U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents

		Document Number	Date	Country	Class	Subclass	Translation Yes	Translation No
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	Van Wyk, G.N., et al., "Ion Bombardment Induced Preferential Orientation in Polycrystalline Cu Targets", Radiation Effects, Vol. 38, 1978, pp. 245-247.
	AS	Wang, C.P. et al., "Deposition of In-Plane Textured MgO on Amorphous Si_3N_4 Substrates by Ion-Beam-Assisted Deposition and Comparisons with Ion-Beam-Assisted Deposited Yttria-Stabilized-Zirconia", Appl. Phys. Lett. 71 (20), 17 November 1997, pp. 2955-2957.
	AT	

Examiner	Date Considered
	11/23/04

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